# **Power MOSFET** 40 V, 8.1 mΩ, 49 A, Single N–Channel

#### Features

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- LFPAK4 Package, Industry Standard
- These Devices are Pb-Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

	Parameter Symbol Value Unit				
Parar	neter		Symbol	Value	Unit
Drain-to-Source Voltage		V <sub>DSS</sub>	40	V	
Gate-to-Source Voltage		V <sub>GS</sub>	±20	V	
Continuous Drain	Steady State	$T_{C} = 25^{\circ}C$	I <sub>D</sub>	49	А
Current R <sub>θJC</sub> (Notes 1, 3)	Sidle	T <sub>C</sub> = 100°C		35	]
Power Dissipation		$T_{C} = 25^{\circ}C$	PD	38	W
$R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 100°C		19	
Continuous Drain	Steady State	$T_A = 25^{\circ}C$	I <sub>D</sub>	16	А
Current R <sub>θJA</sub> (Notes 1, 2, 3)	Sidle	$T_A = 100^{\circ}C$		11	]
Power Dissipation		$T_A = 25^{\circ}C$	PD	3.8	W
$R_{\theta JA}$ (Notes 1, 2)		$T_A = 100^{\circ}C$		1.9	
Pulsed Drain Current	T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	255	А
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C	
Source Current (Body Diode) I <sub>S</sub> 31		31	А		
Single Pulse Drain-to-S Energy (I <sub>L(pk)</sub> = 2.9 A)			mJ		
Lead Temperature for S (1/8" from case for 10 s)	ergy ( $I_{L(pk)} = 2.9 \text{ A}$ ) ad Temperature for Soldering Purposes $T_L$ 260		260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	4.0	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
Maximum current for pulses as long as 1 second is higher but is dependent.

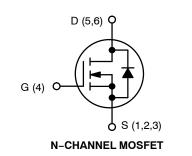
Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

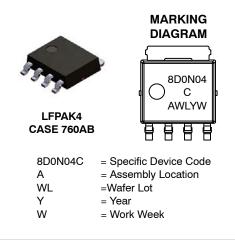


## **ON Semiconductor®**

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	8.1 mΩ @ 10 V	49 A





### **ORDERING INFORMATION**

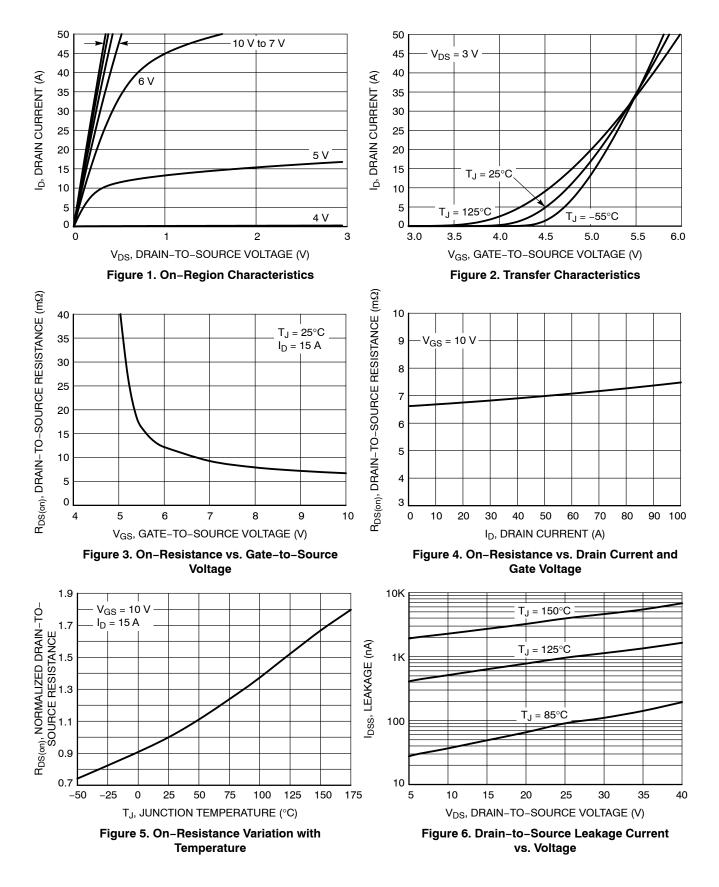
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

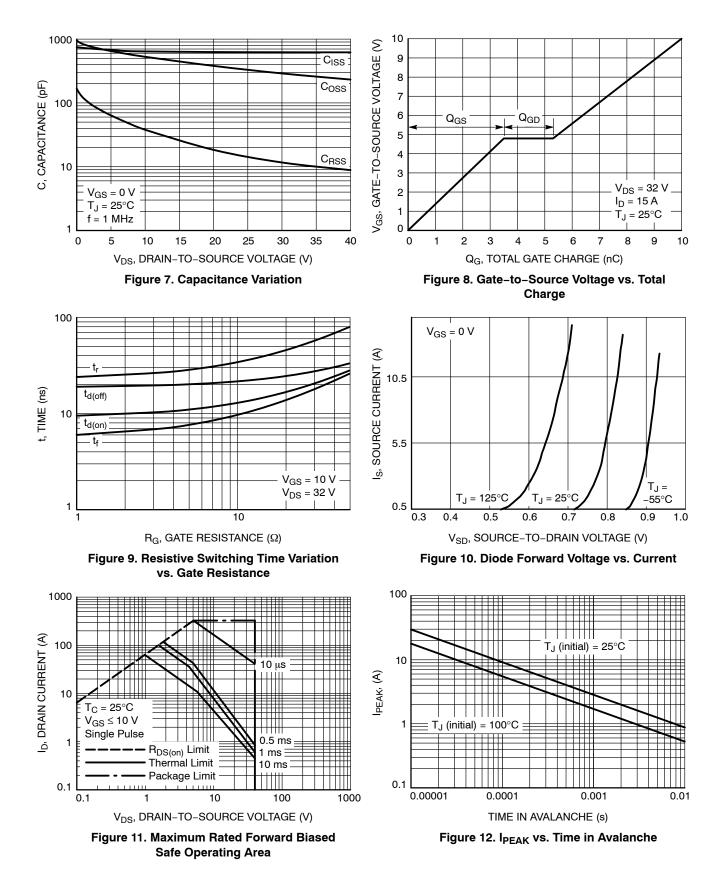
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				23		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	T <sub>J</sub> = 25 °C			10	μA
		$V_{DS} = 40 V$	T <sub>J</sub> = 125°C			250	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 30 μA	2.5		3.5	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-7		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I <sub>D</sub> = 15 A		6.7	8.1	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> =15 V, I <sub>D</sub>	= 15 A		29		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			625		pF
Output Capacitance	C <sub>OSS</sub>				335		-
Reverse Transfer Capacitance	C <sub>RSS</sub>				15		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V; I <sub>D</sub> = 15 A			10		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				2.2		nC
Gate-to-Source Charge	Q <sub>GS</sub>				3.5		
Gate-to-Drain Charge	Q <sub>GD</sub>				1.8		
Plateau Voltage	V <sub>GP</sub>				4.8		V
SWITCHING CHARACTERISTICS (Note 5	5)					-	
Turn-On Delay Time	t <sub>d(ON)</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub> I <sub>D</sub> = 15 A, R <sub>G</sub>	<sub>S</sub> = 32 V,		9.5		ns
Rise Time	t <sub>r</sub>	I <sub>D</sub> = 15 A, R <sub>G</sub>	= 1 Ω		24		1
Turn–Off Delay Time	t <sub>d(OFF)</sub>				19		1
Fall Time	t <sub>f</sub>				6		1
DRAIN-SOURCE DIODE CHARACTERIS	TICS					•	
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$		0.84	1.2	V
		I <sub>S</sub> = 15 A	T <sub>J</sub> = 125°C		0.71		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, dI <sub>S</sub> /dt = 100 A/µs, I <sub>S</sub> = 15 A			24		ns
Charge Time	t <sub>a</sub>				11		1
Discharge Time	t <sub>b</sub>				12		1
Reverse Recovery Charge	Q <sub>RR</sub>				11		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width  $\leq 300 \ \mu$ s, duty cycle  $\leq 2\%$ . 5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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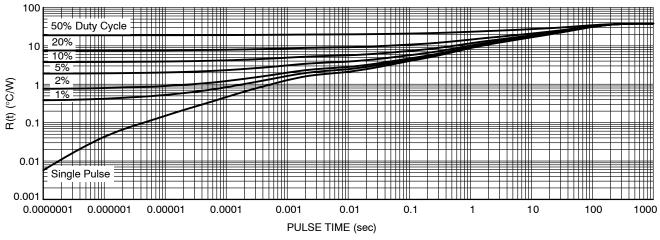


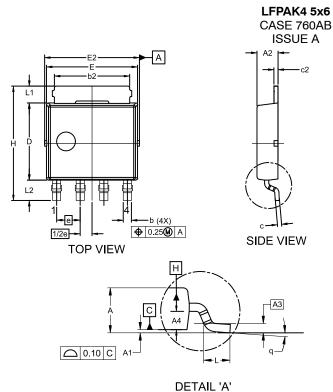
Figure 13. Thermal Characteristics

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMYS8D0N04CTWG	8D0N04C	LFPAK4 (Pb–Free)	3000 / Tape & Reel

<sup>+</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



SCALE: 2:1 4 350 3.500 1.300 b4 0.875 1 610 D3 - 0.600 J f 0 700 1.060 Ŧ 0.700 **RECOMMENDED MOUNTING** 

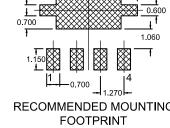
NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: 2. MILLIMETERS.
- 3 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE
- DIMENSIONS D AND E ARE 4 DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. 5. DATUMS A AND B ARE
  - DETERMINED AT DATUM PLANE H.

UNIT IN MILLIMETER					
DIM	MIN	NOM	MAX		
А	1.10	1.20	1.30		
A1	0.00	0.08	0.15		
A2	1.10	1.15	1.20		
A3		0.25			
A4	0.45	0.50	0.55		
b	0.40	0.45	0.50		
b2	3.80	4.10	4.40		
b3	2.00	2.10	2.20		
b4	0.70	0.80	0.90		
С	0.19	0.22	0.25		
c2	0.19	0.22	0.25		
D	4.05	4.15	4.25		
D1	-	-	4.20		
D2	3.0	3.10	3.20		
D3	0.30	0.40	0.50		
Е	4.80	4.90	5.00		
E1	3.10	3.20	3.30		
E2	5.00	5.15	5.30		
е	1.27 BSC				
Н	6.00	6.15	6.30		
L	0.40	0.65	0.85		
L1	0.80	0.90	1.00		
L2	0.80	1.05	1.30		
q 0° 4° 8°					

D2 D1 Ē ₿

BOTTOM VIEW



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